High-Speed, Current Feedback Operational Amplifier

OP-160

FEATURES

- **Easy To Use – Drives Large Capacitive Loads**
- **Very High Slew Rate (A_V = +1) ..... 1300 V/µs Typ**
- **Bandwidth (A_V = +1) ..... 90MHz Typ**
- **Low Supply Current ..... 6.5mA Typ**
- **Bandwidth Independent of Gain**
- **Unity-Gain Stable**
- **Power Shutdown Pin**

APPLICATIONS

- **High-Speed Data Acquisition**
- **Communication Systems/RF Amplifiers**
- **Video Gain Block**
- **High-Speed Integrators**
- **Driving High-Speed ADCs**

ORDERING INFORMATION †

T_A = +25°C V_{IOS} MAX (mV)	PACKAGE CERDIP 8-PIN	PACKAGE PLASTIC 8-PIN	PACKAGE LCC 20-CONTACT	OPERATING TEMPERATURE RANGE
5.0	OP160AZ*	—	OP160ARC/883	MIL
5.0	OP160FZ	OP160GP	—	XIND
5.0	—	OP160GS††	—	XIND

* For devices processed in total compliance to MIL-STD-883, add /883 after part number. Consult factory for 883 data sheet.

† Burn-in is available on extended industrial temperature range parts in CerDIP and plastic packages.

†† For availability and burn-in information on SO package, contact your local sales office.

GENERAL DESCRIPTION

The OP-160 is an easy-to-use high-speed, current feedback op amp. Designed to handle large capacitive loads, the OP-160 resists unstable operation. The OP-160 combines PMI's high-speed complementary bipolar process with a current feedback topology for very high slew rate and wide bandwidth performance.

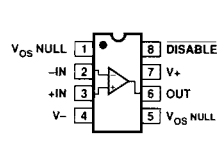
Slew rate of the OP-160 is typically 1300V/µs and is guaranteed to exceed 1000V/µs. In addition, the OP-160's current feedback design has the added advantage of nearly constant bandwidth versus gain. In a gain of +1 the –3dB bandwidth is 90MHz! The OP-160 also requires only 6.5mA of supply current, a considerable power savings over other high-speed amplifiers.

Applications using the OP-160 can be implemented with the same circuit assumptions utilized for conventional voltage feedback op amps. With its high speed and bandwidth, the OP-160 is ideal for a variety of applications including video amplifiers, RF amplifiers, and high-speed data acquisition systems.

The OP-160 is an easy-to-use alternative to the AD844, AD846, EL2020 and EL2030.

For applications requiring a high-speed, wide bandwidth dual amplifier, see the OP-260.

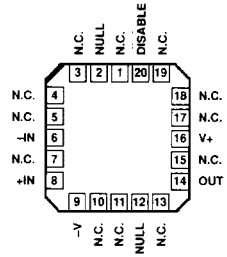
PIN CONNECTIONS



8-PIN EPOXY MINI-DIP (P-Suffix)

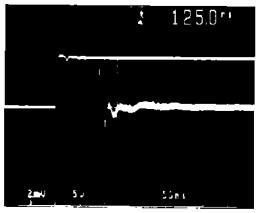
8-PIN CERDIP (Z-Suffix)

8-PIN SO (S-Suffix)



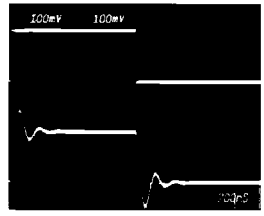
20-CONTACT LCC (RC-Suffix)

FAST SETTLING (0.01%)



A_V = –1, +10V STEP INPUT

DRIVES CAPACITIVE LOADS



A_V = +1, C_L = 1000pF

ABSOLUTE MAXIMUM RATINGS (Note 1)

Supply Voltage ..... ±18V
Input Voltage ..... Supply Voltage
Differential Input Voltage ..... ±1V
Inverting Input Current ..... ±7mA Continuous
..... ±20mA Peak
Output Short-Circuit Duration ..... 10 sec
Operating Temperature Range
OP-160A (Z, RC) ..... –55°C to +125°C
OP-160A,F (Z) ..... –40°C to +85°C
OP-160G (P,S) ..... –40°C to +85°C
Storage Temperature (Z, RC) ..... –65°C to +175°C
(P, S) ..... –65°C to +150°C
Junction Temperature (Z, RC) ..... –65°C to +175°C
(P, S) ..... –65°C to +150°C
Lead Temperature (Soldering, 10 sec) ..... +300°C

PACKAGE TYPE	Θ_{JA} (Note 2)	Θ_{JC}	UNITS
8-Pin Hermetic DIP (Z)	148	16	°C/W
8-Pin Plastic DIP (P)	103	43	°C/W
20-Contact LCC (RC)	98	38	°C/W
8-Pin SO (S)	158	43	°C/W

NOTES:
1. Absolute maximum ratings apply to both DICE and packaged parts, unless otherwise noted.
2. Θ_{JA} is specified for worst case mounting conditions, i.e., Θ_{JA} is specified for device in socket for CerDIP, P-DIP, and LCC packages; Θ_{JA} is specified for device soldered to printed circuit board for SO package.

ELECTRICAL CHARACTERISTICS at V_S = ±15V, V_{CM} = 0V, R_F = 820Ω, T_A = +25°C, unless otherwise noted.

PARAMETER	SYMBOL	CONDITIONS		OP-160A/F MIN	OP-160A/F TYP	OP-160A/F MAX	OP-160G MIN	OP-160G TYP	OP-160G MAX	UNITS
Input Offset Voltage	V_{IOS}			–	2	5	–	2	5	mV
Input Bias Current	I_{B+}	Noninverting Input		–	0.2	1	–	0.4	1.5	µA
	I_{B-}	Inverting Input		–	6	20	–	10	30	
Input Bias Current Common-Mode Rejection Ratio		V_{CM} = ±11V								nA/V
	$CMRR_{B+}$	Noninverting Input		–	40	75	–	50	125	
	$CMRR_{B-}$	Inverting Input		–	30	75	–	40	125	
Input Bias Current Power Supply Rejection Ratio		V_S = ±9V to ±18V								nA/V
	$PSRR_{B+}$	Noninverting Input		–	1	5	–	1.5	10	
	$PSRR_{B-}$	Inverting Input		–	20	50	–	25	75	
Common-Mode Rejection	CMR	V_{CM} = ±11V		60	65	–	60	65	–	dB
Power Supply Rejection	PSR	V_S = ±9V to ±18V		74	80	–	74	80	–	dB
Open-Loop Transimpedance	R_T	R_L = 500Ω V_O = ±10V		3	4	–	3	4	–	MΩ
Input Voltage Range	IVR	(Note 1)		±11	–	–	±11	–	–	V
Output Voltage Swing	V_O	R_L = 500Ω		±11	–	–	±11	–	–	V
Output Current	I_O	V_O = ±10V		±35	+60/–45	–	±35	+60/–45	–	mA
Supply Current	I_{SY}	No Load		–	6.5	8	–	6.5	8	mA
Slew Rate	SR	A_V = +1, V_O = ±10V, R_L = 500Ω, Test at V_O = ±5V	All Grades	–	1300	–	–	1300	–	V/µs
		A_V = +2, V_O = ±10V, R_L = 500Ω, Test at V_O = ±5V	OP-160A	1000	1300	–	–	–	–	
			OP-160F	800	1300	–	–	–	–	
			OP-160G	–	–	–	800	1300	–	

ELECTRICAL CHARACTERISTICS at $V_S = \pm 15V$, $V_{CM} = 0V$, $R_F = 820\Omega$, $T_A = +25°C$, unless otherwise noted. *Continued*

PARAMETER	SYMBOL	CONDITIONS		OP-160A/F MIN	OP-160A/F TYP	OP-160A/F MAX	OP-160G MIN	OP-160G TYP	OP-160G MAX	UNITS
Rise Time	t_R	$A_V = +1$ $A_V = -1$	$V_O = \pm 100mV$	– –	4 6.4	– –	– –	4 6.4	– –	ns
–3dB Bandwidth	BW	–3dB Point $R_L = 500\Omega$	$A_V = -1$ $A_V = +1$ $A_V = +2$	– – –	55 90 65	– – –	– – –	55 90 65	– – –	MHz
Settling Time	t_s	$A_V = -1$, 10V Step 0.01% 0.1%		– –	125 75	– –	– –	125 75	– –	ns
Input Capacitance	C_{IN}	Noninverting Input		–	4	–	–	4	–	pF
Input Resistance	R_{IN}	Noninverting Input Inverting Input		– –	17 60	– –	– –	10 60	– –	MΩ Ω
Voltage Noise Density	e_n	$f = 1kHz$		–	5.5	–	–	5.5	–	$nV/\sqrt{Hz}$
Current Noise Density	i_n	$f = 1kHz$ Noninverting Input Inverting Input		– –	5 20	– –	– –	5 20	– –	$pA/\sqrt{Hz}$
Total Harmonic Distortion	THD	$f = 1kHz$, $A_V = +1$, $V_O = 2V_{RMS}$, $R_L = 500\Omega$		–	0.004	–	–	0.004	–	%
Differential Gain		$f = 3.58MHz$ $A_V = +1$, $R_L = 500\Omega$		–	0.04	–	–	0.04	–	%
Differential Phase		$f = 3.58MHz$ $A_V = +1$, $R_L = 500\Omega$		–	0.04	–	–	0.04	–	degrees
Disable Supply Current	$I_{SY\overline{DIS}}$	$\overline{DISABLE} = 0V$ No Load		–	2.3	–	–	2.3	–	mA

NOTE:
1. Guaranteec by CMR test.

ELECTRICAL CHARACTERISTICS at $V_S = \pm 15V$, $V_{CM} = 0V$, $R_F = 820\Omega$, $-55°C \le T_A \le +125°C$, for the OP-160A, unless otherwise noted.

			OP-160A			
PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Input Offset Voltage	V_{IOS}		–	3	8	mV
Average Input Offset Voltage Drift	TC_{VOS}		–	10	–	µV/°C
Input Bias Current	I_{B+} I_{B-}	Noninverting Input Inverting Input	– –	0.35 12	2 30	µA
Input Bias Current Common-Mode Rejection	$CMRRI_{B+}$ $CMRRI_{B-}$	$V_{CM} = \pm 10V$ Noninverting Input Inverting Input	– –	55 45	150 150	nA/V
Input Bias Current Power Supply Rejection Ratio	$PSRRI_{B+}$ $PSRRI_{B-}$	$V_S = \pm 9V$ to $\pm 18V$ Noninverting Input Inverting Input	– –	2 40	10 100	nA/V
Common-Mode Rejection	CMR	$V_{CM} = \pm 10V$	56	60	–	dB
Power Supply Rejection	PSR	$V_S = \pm 9V$ to $\pm 18V$	70	76	–	dB
Open-Loop Transimpedance	R_T	$R_L = 500\Omega$ $V_O = \pm 10V$	1.75	3	–	MΩ
Input Voltage Range	IVR	(Note 1)	±10	–	–	V
Output Voltage Swing	V_O	$R_L = 500\Omega$	±10	–	–	V
Supply Current	I_{SY}	No Load	–	6.75	9	mA

NOTE:
1. Guaranteed by CMR test.

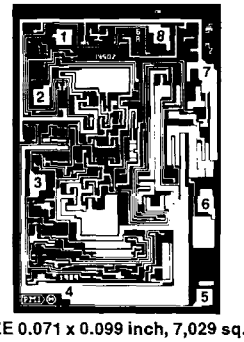
ELECTRICAL CHARACTERISTICS at $V_S = \pm 15V$, $V_{CM} = 0V$, $R_F = 820\Omega$, $-40°C \le T_A \le +85°C$, for the OP-160F/G, unless otherwise noted.

PARAMETER	SYMBOL	CONDITIONS	OP-160F MIN	OP-160F TYP	OP-160F MAX	OP-160G MIN	OP-160G TYP	OP-160G MAX	UNITS
Input Offset Voltage	V_{IOS}		–	2.75	8	–	2.75	8	mV
Average Input Offset Voltage	TCV_{OS}		–	10	–	–	10	–	µV/°C
Input Bias Current	I_{B+} I_{B-}	Noninverting Input Inverting Input	– –	0.3 10	2 30	– –	0.5 15	3 40	µA
Input Bias Current Common-Mode Rejection Ratio	$CMRRI_{B+}$ $CMRRI_{B-}$	$V_{CM} = \pm 10V$ Noninverting Input Inverting Input	– –	45 35	150 150	– –	55 45	250 250	nA/V
Input Bias Current Power Supply Rejection Ratio	$PSRRI_{B+}$ $PSRRI_{B-}$	$V_S = \pm 9V$ to $\pm 18V$ Noninverting Input Inverting Input	– –	1.5 30	10 100	– –	2.5 3.5	20 150	nA/V
Common-Mode Rejection	CMR	$V_{CM} = \pm 10V$	56	62	–	56	62	–	dB
Power Supply Rejection	PSR	$V_S = \pm 9V$ to $\pm 18V$	70	80	–	70	80	–	dB
Open-Loop Transimpedance	R_T	$R_L = 500\Omega$ $V_O = \pm 10V$	1.75	3	–	1.75	3	–	MΩ
Input Voltage Range	IVR	(Note 1)	±10	–	–	±10	–	–	V
Output Voltage Swing	V_O	$R_L = 500\Omega$	±10	–	–	±10	–	–	V
Supply Current Current	I_{SY}	No Load, Both Amplifiers	–	6.75	9	–	6.75	9	mA

NOTE:
1. Guaranteed by CMR test.

OP-160

DICE CHARACTERISTICS



DIE SIZE 0.071 x 0.099 inch, 7,029 sq. mils
(1.80 x 2.52 mm, 4.54 sq. mm)

1. V_{OS} NULL
2. –IN
3. +IN
4. V–
5. V_{OS} NULL
6. OUT
7. V+
8. $\overline{\text{DISABLE}}$

WAFER TEST LIMITS at $V_S = \pm 15V$, $V_{CM} = 0V$, $R_F = 820\Omega$, $T_A = +25°C$, unless otherwise noted.

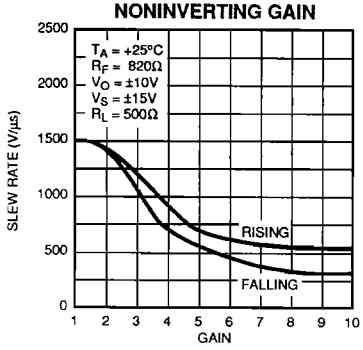
PARAMETER	SYMBOL	CONDITIONS	OP-160GBC LIMITS	UNITS
Input Offset Voltage	V_{IOS}		5	mV MAX
Input Bias Current	I_{B+} I_{B-}	Noninverting Input Inverting Input	1.5 30	µA MAX
Input Bias Current Common-Mode Rejection Ratio	 $CMRRI_{B+}$ $CMRRI_{B-}$	$V_{CM} = \pm 11V$ Noninverting Input Inverting Input	 125 125	nA/V MAX
Input Bias Current Power Supply Rejection Ratio	 $PSRRI_{B+}$ $PSRRI_{B-}$	$V_S = \pm 9V$ to $\pm 18V$ Noninverting Input Inverting Input	 10 75	nA/V MAX
Common-Mode Rejection	CMR	$V_{CM} = \pm 11V$	60	dB MIN
Power Supply Rejection	PSR	$V_S = \pm 9V$ to $\pm 18V$	74	dB MIN
Open-Loop Transimpedance	R_T	$R_L = 500\Omega$ $V_O = \pm 10V$	3	MΩ MIN
Input Voltage Range	IVR		±11	V MIN
Output Voltage Swing	V_O	$R_L = 500\Omega$	±11	V MIN
Supply Current	I_{SY}	No Load	8	mA MAX

NOTES:
1. Guaranteed by CMR test.

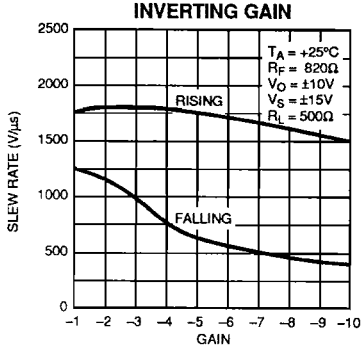
Electrical tests are performed at wafer probe to the limits shown. Due to variations in assembly methods and normal yield loss, yield after packaging is not guaranteed for standard product dice. Consult factory to negotiate specifications based on dice lot qualifications through sample lot assembly and testing.

TYPICAL PERFORMANCE CHARACTERISTICS

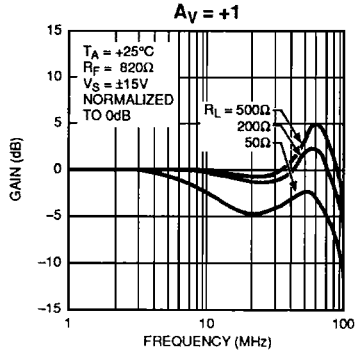
SLEW RATE vs NONINVERTING GAIN



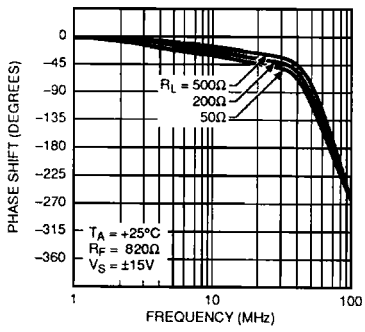
SLEW RATE vs INVERTING GAIN



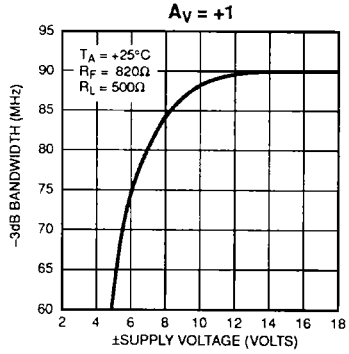
GAIN vs FREQUENCY A_V = +1



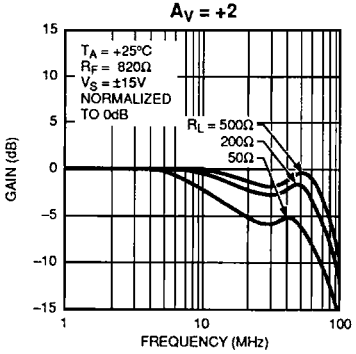
PHASE SHIFT vs FREQUENCY A_V = +1



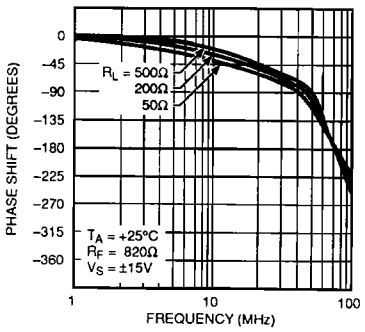
–3dB BANDWIDTH vs SUPPLY VOLTAGE A_V = +1



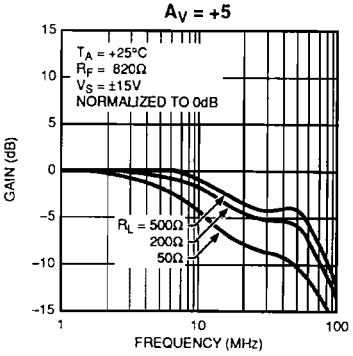
GAIN vs FREQUENCY A_V = +2



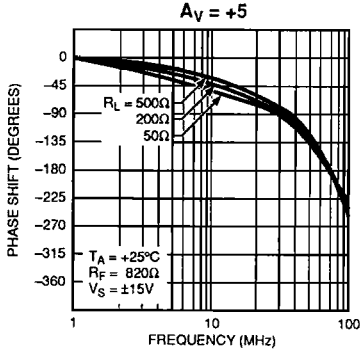
PHASE SHIFT vs FREQUENCY A_V = +2



GAIN vs FREQUENCY A_V = +5

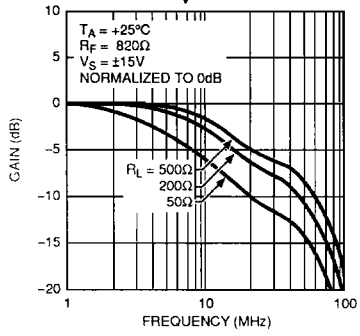


PHASE SHIFT vs FREQUENCY A_V = +5

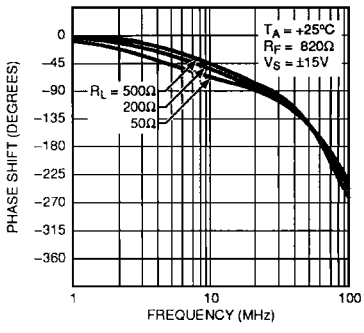


TYPICAL PERFORMANCE CHARACTERISTICS *Continued*

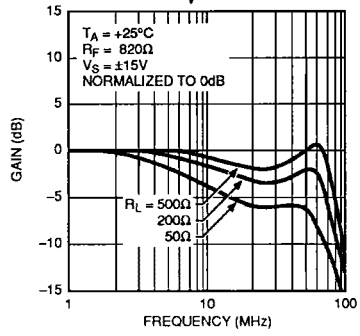
GAIN vs FREQUENCY
A_V = +10



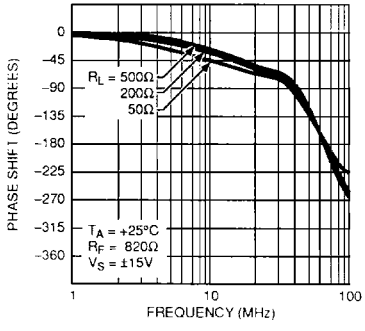
PHASE SHIFT vs FREQUENCY
A_V = +10



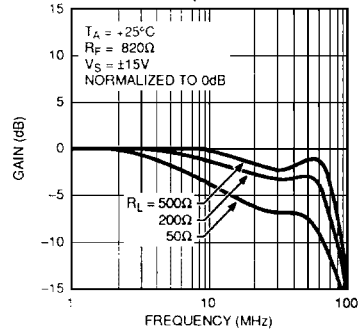
GAIN vs FREQUENCY
A_V = –1



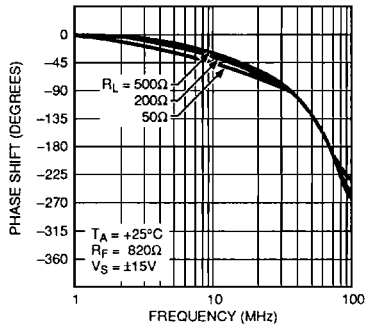
PHASE SHIFT vs FREQUENCY
A_V = –1



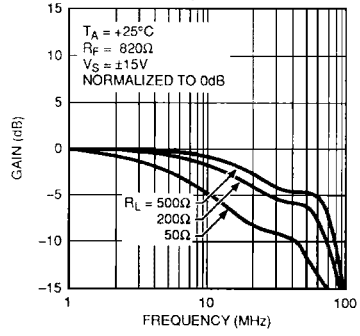
GAIN vs FREQUENCY
A_V = –2



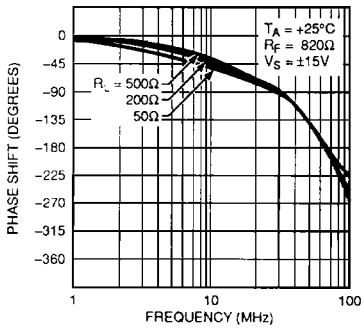
PHASE SHIFT vs FREQUENCY
A_V = –2



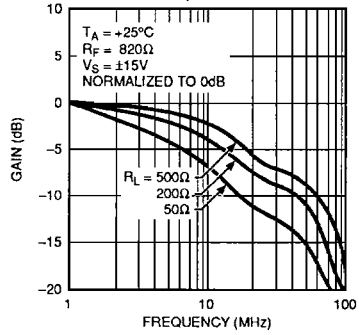
GAIN vs FREQUENCY
A_V = –5



PHASE SHIFT vs FREQUENCY
A_V = –5

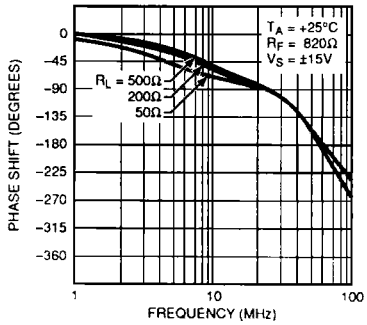


GAIN vs FREQUENCY
A_V = –10

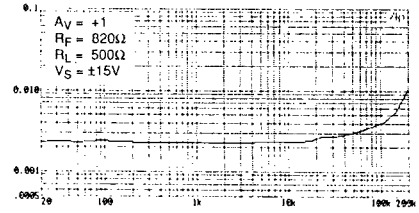


TYPICAL PERFORMANCE CHARACTERISTICS *Continued*

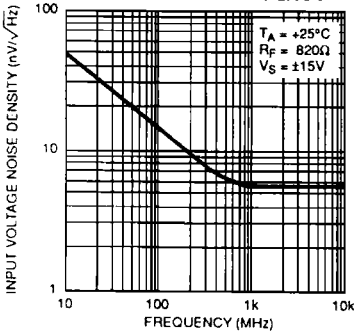
PHASE SHIFT vs FREQUENCY
A_V = –10



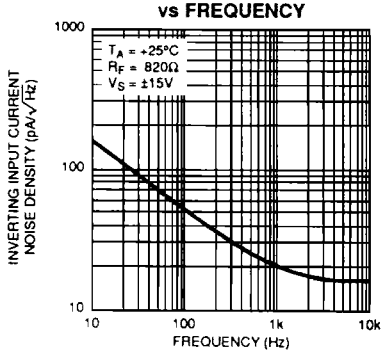
TOTAL HARMONIC DISTORTION vs FREQUENCY



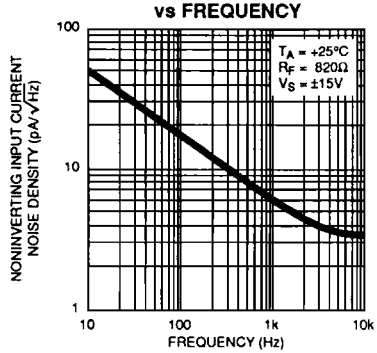
INPUT VOLTAGE NOISE DENSITY vs FREQUENCY



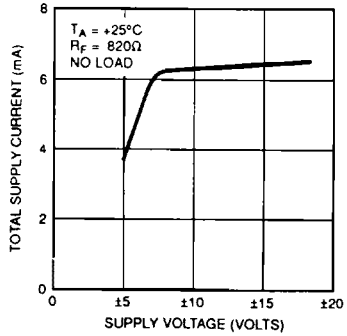
INVERTING INPUT CURRENT NOISE DENSITY vs FREQUENCY



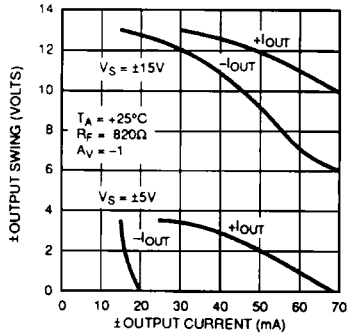
NONINVERTING INPUT CURRENT NOISE DENSITY vs FREQUENCY



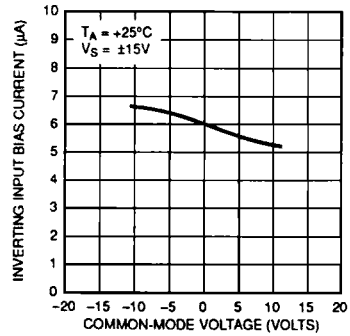
TOTAL SUPPLY CURRENT vs SUPPLY VOLTAGE



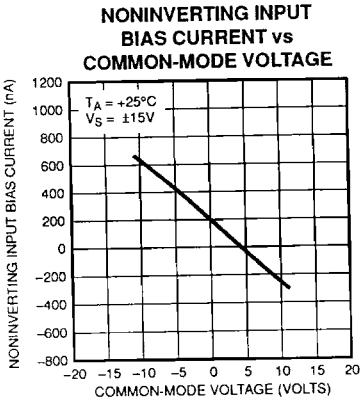
OUTPUT CURRENT vs OUTPUT SWING

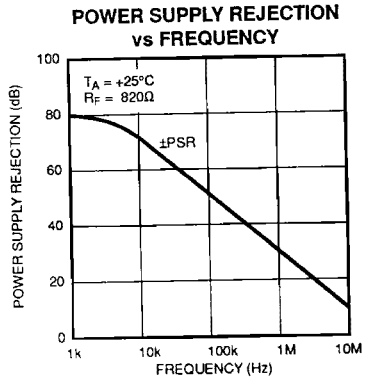


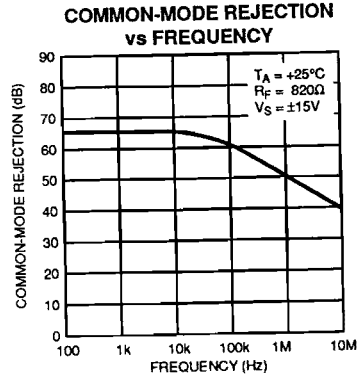
INVERTING INPUT BIAS CURRENT vs COMMON-MODE VOLTAGE



TYPICAL PERFORMANCE CHARACTERISTICS *Continued*







APPLICATIONS INFORMATION

CURRENT VERSUS VOLTAGE FEEDBACK AMPLIFIERS

The OP-160 employs a unique circuit topology that sets it apart from conventional op amps. By using a transimpedance amplifier configuration, the OP-160 provides substantial improvements in bandwidth and slew rate over voltage feedback op amps. Figure 1 compares models of these two different amplifier configurations.

A voltage feedback op amp multiplies the differential voltage at its inputs by its open-loop gain. The feedback loop forces the output to a voltage that, when divided by R_1 and R_2, equalizes the input voltages. Unlike a voltage feedback op amp, which has high impedance inputs, the current feedback amplifier has a high and a low impedance input. The current feedback amplifier's input stage consists of a unity-gain voltage buffer between the noninverting and inverting inputs. The inverting "input" is in reality a low impedance output. Current can flow into or out of the inverting input. A transimpedance stage follows the input buffer that converts the buffer output current into a linearly proportional amplifier output voltage.

The current feedback amplifier loop works in the following fashion (Figure 1b). As the noninverting input voltage rises, the inverting input follows and the buffer sources current through R_1.

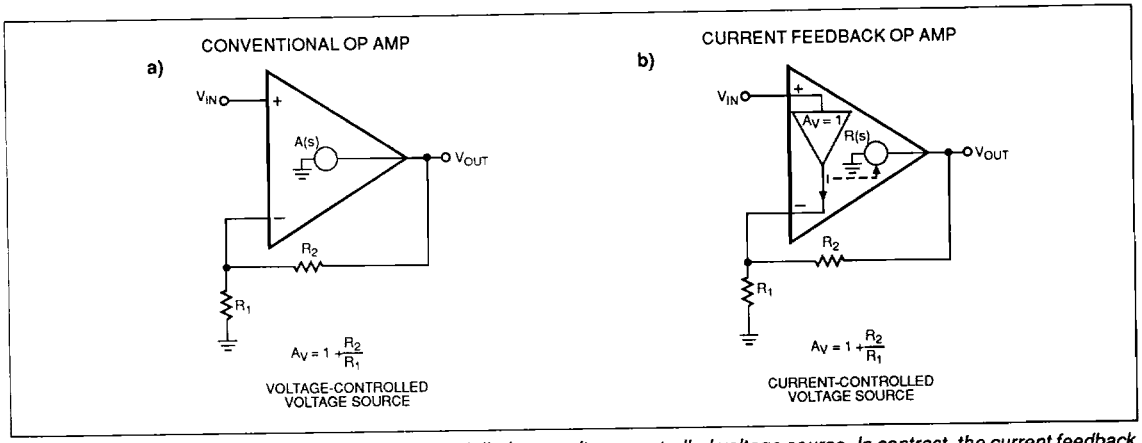


FIGURE 1: *The conventional op amp (a) can be modelled as a voltage-controlled voltage source. In contrast, the current feedback op amp (b), resembles a current-controlled voltage source.*

This current, multiplied by the transimpedance stage, causes the amplifier's output voltage to rise until the current flowing into R_2 from the amplifier's output equalizes the current through R_1, replacing the buffer's output current. At steady state, only a very small buffer output current must flow to sustain the proper output voltage. The ratio $(1 + R_2/R_1)$ determines the closed-loop gain of the circuit. The result is that when designing with current feedback amplifiers the familiar op amp assumptions can still be used for circuit analysis:

1. The voltage across the inputs equals zero.
2. The current into the inputs equals zero.

BANDWIDTH VERSUS GAIN

A unique feature of the current feedback amplifier design is that the closed-loop bandwidth remains relatively constant as a function of closed-loop gain. Voltage feedback op amps suffer from a bandwidth reduction as closed-loop gain increases, as quantified by the gain-bandwidth product (GBWP). This is illustrated in Figure 2 which shows the frequency response of the OP-160 for various closed-loop gains and the frequency response of a voltage feedback op amp with a gain-bandwidth product of 30MHz. The bandwidth of the OP-160 is much less dependent upon closed-loop gain than the voltage feedback op amp.

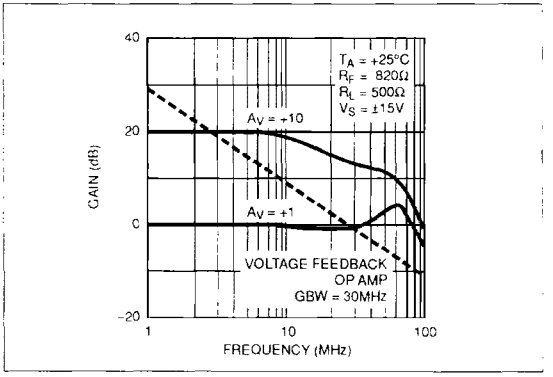


FIGURE 2: *Frequency response of the OP-160 when connected in various closed-loop gains with R_F = 820Ω and R_L = 100Ω. Note that the frequency response of the OP-160 does not follow the asymptotic roll-off characteristic of a voltage feedback op amp.*

FEEDBACK RESISTANCE AND BANDWIDTH

The closed-loop frequency response of the OP-160 shown in Figure 2 applies for a fixed feedback resistor of 820Ω. The frequency response of a current feedback amplifier is primarily dependent on the value of the feedback resistor value. The design of the OP-160 has been optimized for a feedback resistance of 820Ω. By holding the feedback resistor value constant, the –3dB frequency point will also remain constant within a moderate range of closed-loop gain.

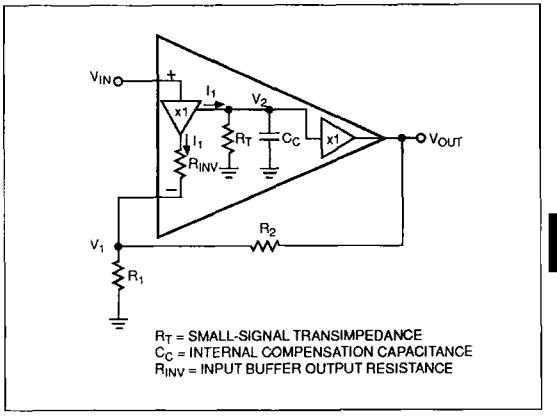


FIGURE 3: *Simple frequency response model of the current feedback amplifier.*

The model shown in Figure 3 can be used to determine the frequency response of a current feedback amplifier. With this model, the frequency response dependency on the value of the feedback resistance is easily seen.

From the model of Figure 3, nodal equations may be written for V_1 and V_2.

$$V_1 = \frac{V_{IN}\left(\frac{R_2}{R_{INV}}\right) + V_{OUT}}{1 + \frac{R_2}{R_1} + \frac{R_2}{R_{INV}}}$$

$$V_2 = \frac{R_T}{1 + sR_T C_C} I_1$$

where $I_1 = \frac{V_{IN} - V_1}{R_{INV}} = V_1\left(\frac{1}{R_1} + \frac{1}{R_2}\right) - \frac{V_{OUT}}{R_2}$, and $V_{OUT} = V_2$

Combining these equations yields:

$$V_{OUT} = \left[\left(\frac{V_{IN}\left(\frac{R_2}{R_{INV}}\right) + V_{OUT}}{1 + \frac{R_2}{R_1} + \frac{R_2}{R_{INV}}}\right)\left(\frac{1}{R_1} + \frac{1}{R_2}\right) - \frac{V_{OUT}}{R_2}\right] \frac{R_T}{1 + sR_T C_C}$$

If the transimpedance of the amplifier, R_T, is » R_2 and R_{INV}, then the transfer function may be simplified to:

$$\frac{V_{OUT}}{V_{IN}} \approx \frac{1 + \frac{R_2}{R_1}}{1 + s\left[R_2 + \left(1 + \frac{R_2}{R_1}\right)R_{INV}\right]C_C}$$

The transfer function shows that the dominant closed-loop pole is mainly dependent on the value of the feedback resistance, R_2, and the internal compensation capacitor, C_C. For example, at unity gain, where R_1 is infinite, R_2 determines the –3dB frequency.

$$\frac{V_{OUT}}{V_{IN}} \approx \frac{1}{1 + sR_2 C_C}$$

$$f_{-3dB} = \frac{1}{2\pi R_2 C_C}$$

where $R_2 \gg R_{INV}$

For higher gains, the –3dB frequency is determined by R_2 plus the output resistance of the buffer, R_{INV} (typically 60Ω), which is multiplied by the closed-loop gain. As the closed-loop gain increases, the multiplying effect on R_{INV} becomes dominant, causing the bandwidth to decrease. However, the closed-loop bandwidth of a current feedback amplifier still far exceeds that of a voltage feedback op amp for moderate values of gain.

Figure 4 shows the effect of the feedback resistance on the bandwidth of the OP-160 for various closed-loop gains.

SLEW RATE AND GAIN

The simplified schematic in Figure 5 shows the three stages of the OP-160. The input stage consists of a unity-gain emitter-follower amplifier. Q_5 and Q_6 form a class AB output stage at the inverting input which can source or sink current. The current flowing through the inverting input is sensed by the top current mirror, formed by Q_7, Q_9, and Q_{10}, or the bottom current mirror, formed by Q_8, Q_{11}, and Q_{12}. When the buffer sources current to a load, current flows out of the inverting input, increasing Q_5's collector current and causing more current to flow through Q_9

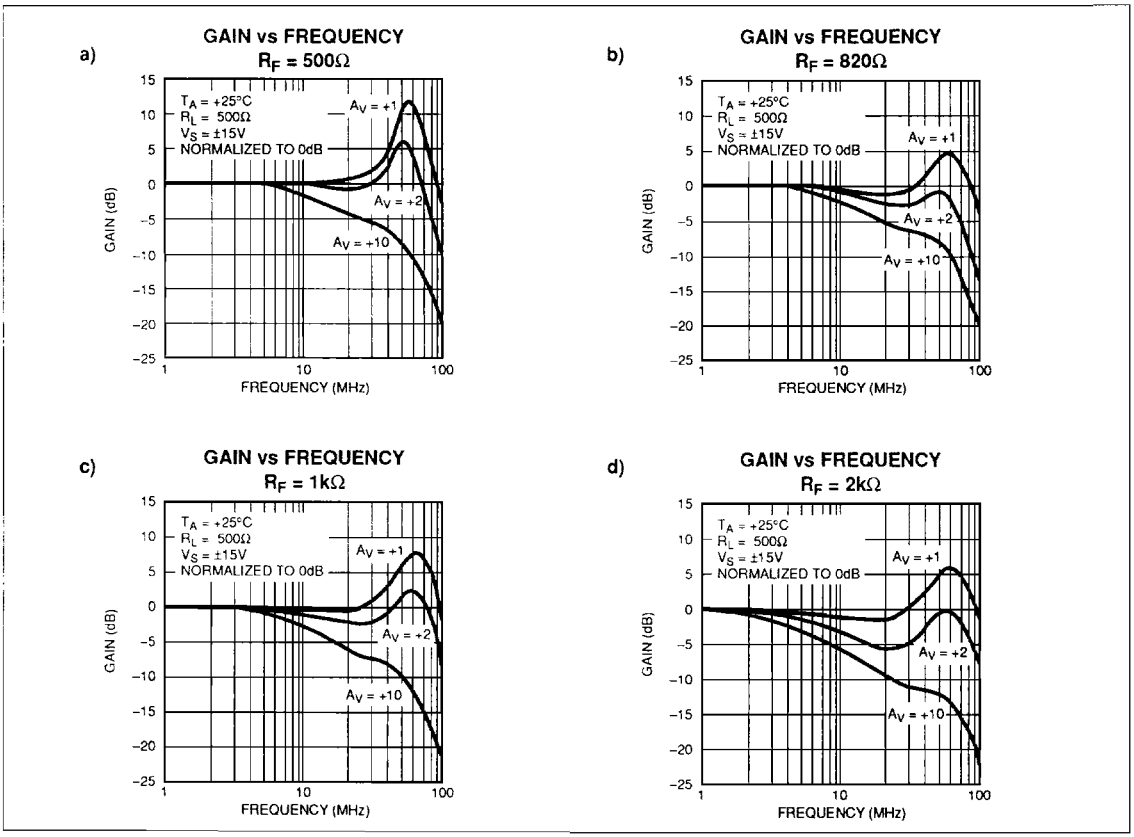


FIGURE 4: *Bandwidth will vary with feedback resistance. Peaking increases as the feedback resistance is decreased. R_F = 820Ω is the recommended value. All graphs are normalized to 0dB.*

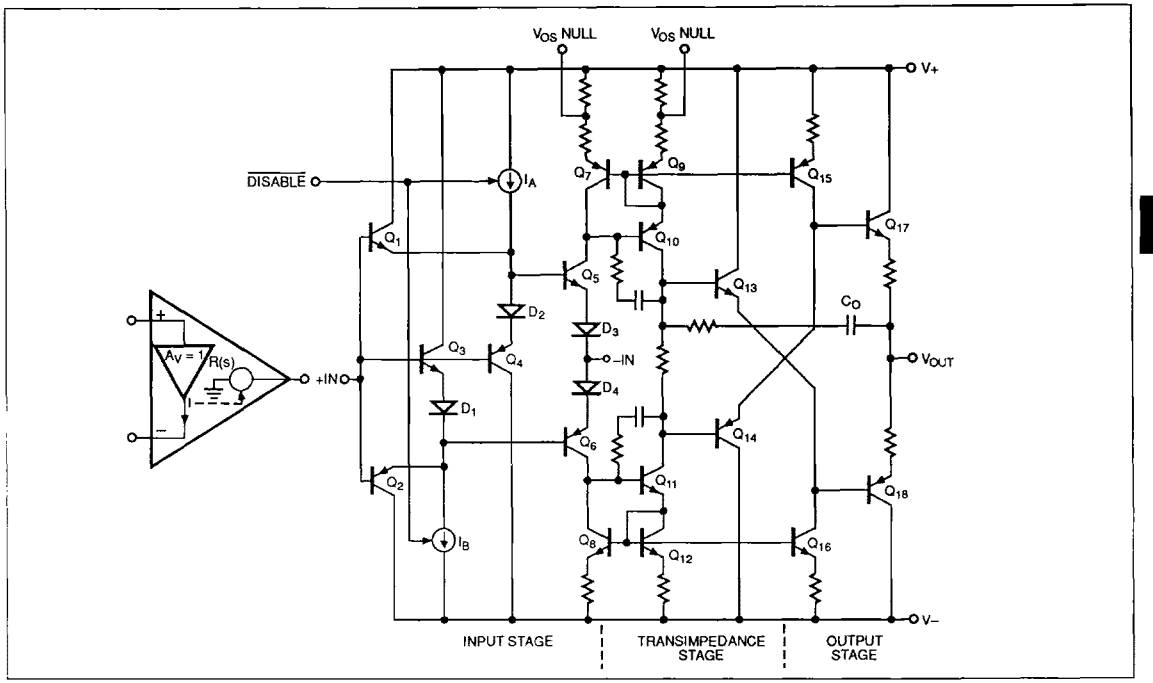


FIGURE 5: *Simplified schematic of the OP-160 showing the three stages of the amplifier.*

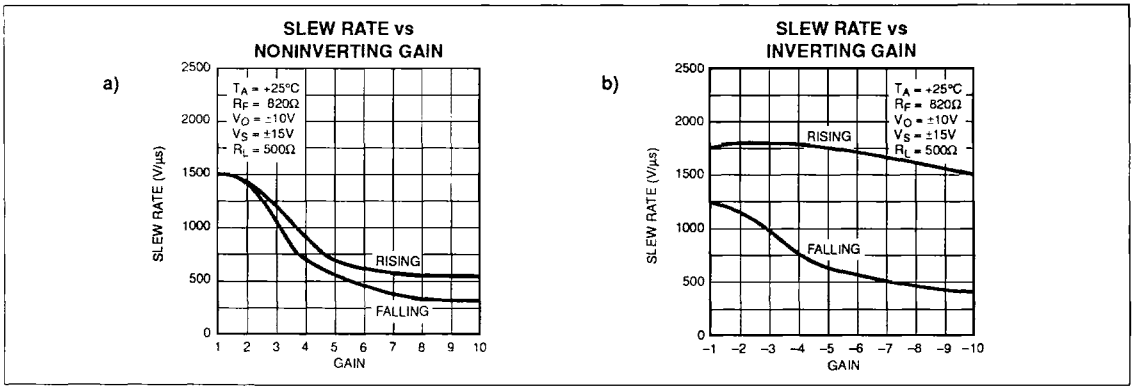


FIGURE 6: *Slew rate of the OP-160 in noninverting (a) and inverting (b) configurations.*

and Q_{15}. This increases the base drive to the output transistor Q_{17}. Simultaneously, the increased current in Q_9 drives Q_{13} which reduces base drive to the complementary output transistor Q_{18}. This push-pull action produces a very fast output slew rate. For a small voltage step, the OP-160's slew rate is dependent on the available current from the two current sources (I_A and I_B) that drive Q_5 and Q_6.

To increase the slew rate, transistors Q_1 and Q_2 have been added to boost the base drive to Q_5 and Q_6. In low gains, a large input step will turn on Q_1 or Q_2 increasing the slew rate dramatically as illustrated in Figure 6.

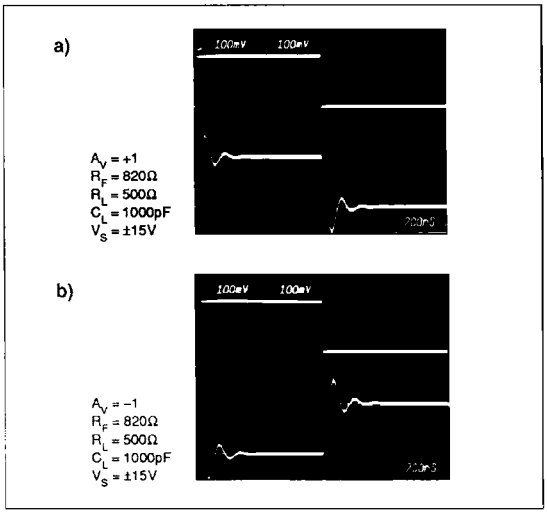


FIGURE 7: *The OP-160 remains stable when driving large capacitive loads.*

DRIVING CAPACITIVE LOADS

The OP-160 is capable of driving capacitive loads at high speed. Output stage compensation is used to reduce the effects of capacitive loading. With low capacitive loads, the gain from the compensation node to the output is unity and C_O does not contribute to the overall compensation. As the load capacitance is increased, a pole is formed with the output resistance of the amplifier. The gain is reduced and C_O begins to contribute to the overall compensation capacitance leading to a reduction in bandwidth. As the load capacitance is increased, the bandwidth is further reduced and the amplifier remains stable. Figure 7 shows the OP-160 in a gain of +1 and −1 driving a 1000pF load without any sign of oscillation. Table 1 shows the effects of capacitive load on the −3dB bandwidth for $A_V = -1$.

TABLE 1: −3dB Bandwidth vs. Capacitive Load; $A_V = -1$, $R_F = 820\Omega$, $R_L = 500\Omega$, $V_S = \pm 15V$.

CAPACITANCE (pF)	−3dB BANDWIDTH (MHz)
0	55
20	55
50	50
75	48
100	40
200	24
500	13
1000	9

AMPLIFIER NOISE PERFORMANCE

Simplified noise models of the OP-160 in the noninverting and inverting amplifier configurations are shown in Figure 8. All resistors are assumed to be noiseless.

For the noninverting amplifier, the equivalent input voltage noise, referred to the input, is:

$$E_N = \sqrt{(R_S\, i_{nn})^2 + e_n^2 + (R_2\, i_{ni})^2 / A_{VCL}}$$

where:

E_N = total input referred noise
e_n = amplifier voltage noise
i_{nn} = noninverting input current noise
i_{ni} = inverting input current noise
R_S = source resistance
A_{VCL} = closed loop gain = $1 + R_2/R_1$

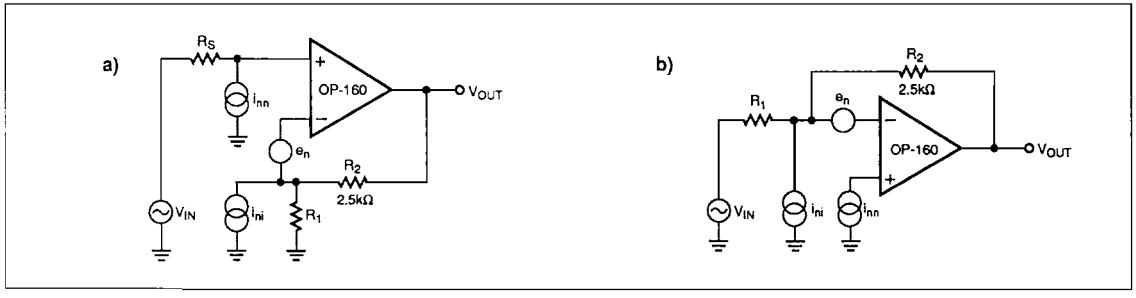


FIGURE 8: *Simplified noise models for the OP-160 in noninverting (a) and inverting (b) gain.*

For the inverting amplifier, the equivalent input voltage noise, referred to the input, is:

$$E_N = \sqrt{e_n^2 \left(\frac{1 + |A_{VCL}|}{|A_{VCL}|}\right) + \frac{(R_2\, i_{ni})^2}{|A_{VCL}|}}$$

assuming $R_S \ll R_1$. A_{VCL} = closed-loop gain = $-R_2/R_1$.

Typical values @ 1kHz for the noise parameters of the OP-160 are:

$e_n = 5.5nV/\sqrt{Hz}$
$i_{nn} = 5pA/\sqrt{Hz}$
$i_{ni} = 20pA/\sqrt{Hz}$

SHORT-CIRCUIT PERFORMANCE

To avoid sacrificing bandwidth and slew rate performance the OP-160's output is **not** short-circuit protected. Do not short the amplifier's output to ground or to the supplies. Also, the buffer output current should not exceed a value of ±20mA peak or ±7mA continuous.

POWER SUPPLY BYPASSING AND LAYOUT CONSIDERATIONS

Proper power supply bypassing is critical in all high-frequency circuit applications. For stable operation of the OP-160, the power supplies must maintain a low impedance-to-ground over an extremely wide bandwidth. This is most critical when driving a low resistance or large capacitance, since the current required to drive the load comes from the power supplies. A 10µF and 0.1µF bypass capacitor are recommended for each supply, as shown in Figure 9, and will provide adequate high-frequency bypassing in most applications. The bypass capacitors should be placed at the supply pins of the OP-160. As with all high frequency amplifiers, circuit layout is a critical factor in obtaining optimum performance from the OP-160. Proper high-frequency layout reduces unwanted signal coupling in the circuit. When breadboarding a high-frequency circuit, use direct point-to-point wiring, keeping all lead lengths as short as possible. Do not use wire-wrap boards or "plug-in" prototyping boards.

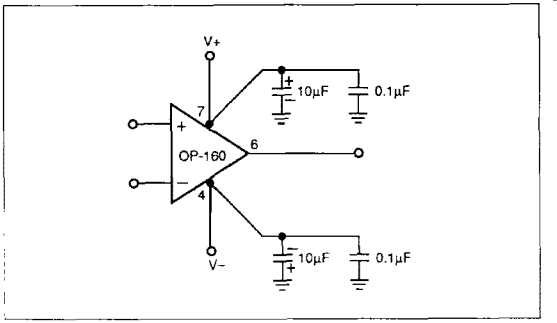


FIGURE 9: *Proper power supplying bypassing is required to obtain optimum performance with the OP-160.*

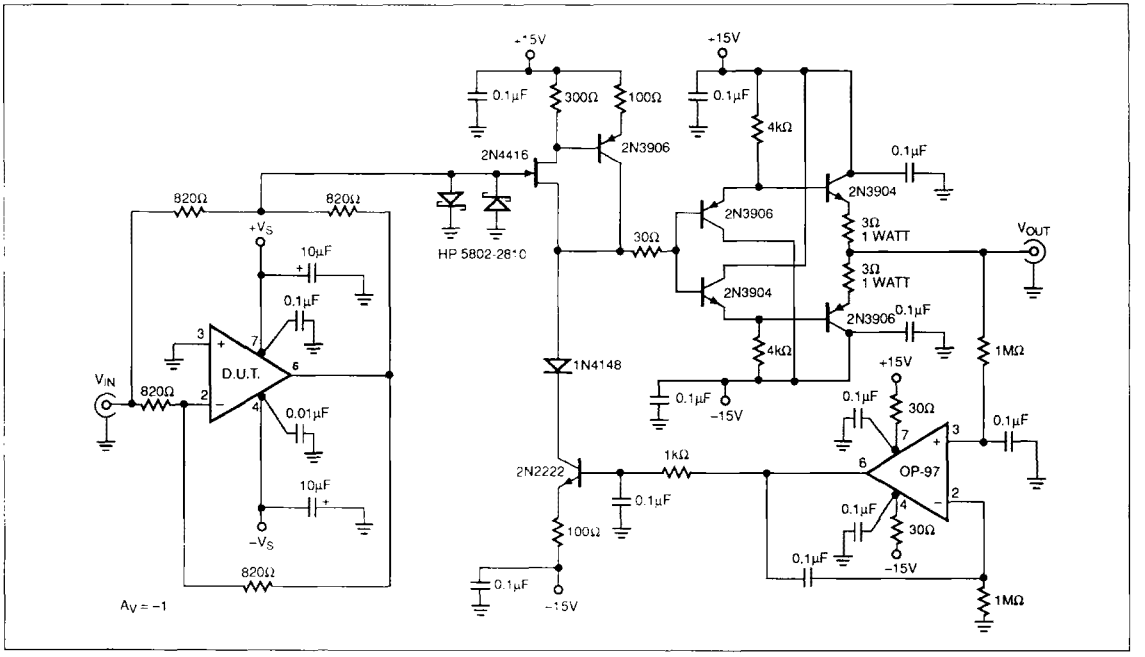


FIGURE 10: *High-Speed Settling Time Fixture (for 0.1 and 0.01%)*

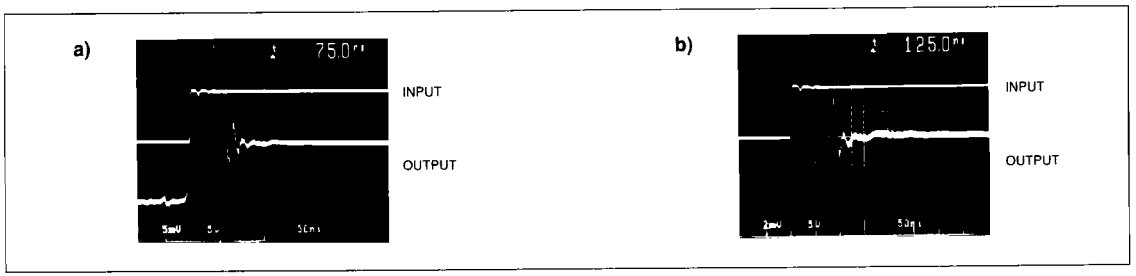


FIGURE 11: *Settling Time Performance of the OP-160 to 0.1% (a) and 0.01% (b) $A_V = -1$*

SETTLING TIME

Settling time is the time between when the input signal begins to change and when the output permanently enters a prescribed error band. Figure 10 illustrates the artificial summing node test configuration, used to characterize the OP-160 settling time. The OP-160 is set in a gain of −1 with a 10V step input. The error bands on the output are 5mV and 0.5mV, respectively, for 0.1% and 0.01% accuracy.

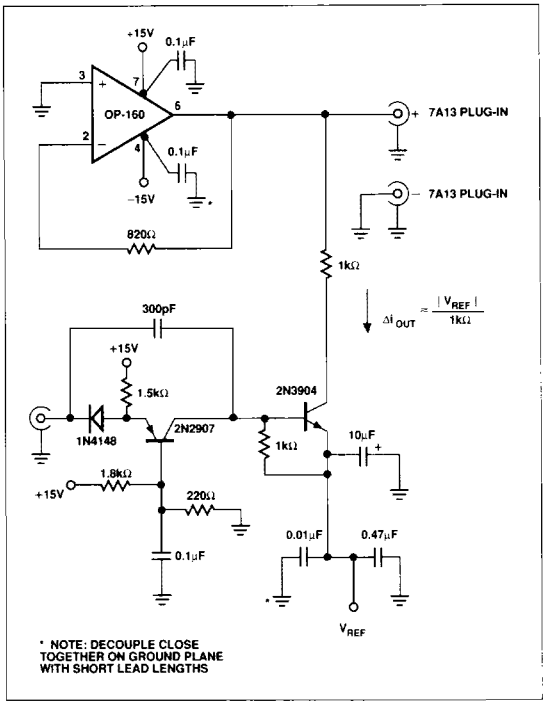


FIGURE 12: *Transient Output Impedance Test Fixture*

The test circuit, built on a copper clad circuit board, has a FET input stage which maintains extremely low loading capacitance at the artificial sum node. Preceding stages are complementary emitter follower stages, providing adequate drive current for a 50Ω oscilloscope input. The OP-97 establishes biasing for the input stage, and eliminates excessive offset voltage errors.

TRANSIENT OUTPUT IMPEDANCE

Settling characteristics of operational amplifiers also includes an amplifier's ability to recover, i.e., settle, from a transient current output load condition. An example of this includes an op amp driving the input from a SAR type A/D converter. Although the comparison point of the converter is usually diode clamped, the input swing of plus-and-minus a diode drop still gives rise to a significant modulation of input current. If the closed-loop output impedance is low enough and bandwidth of the amplifier is sufficiently large, the output will settle before the converter makes a comparison decision which will prevent linearity errors or missing codes.

Figure 12 shows a settling measurement circuit for evaluating recovery from an output current transient. An output disturbing current generator provides the transient change in output load current of 1mA. As seen in Figure 13, the OP-160 has extremely fast recovery of 80ns, (to 0.01%), for a 1mA load transient. The performance makes it an ideal amplifier for data acquisition systems.

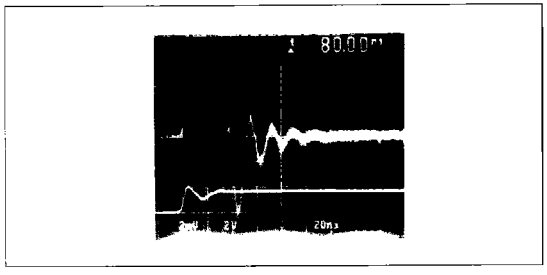


FIGURE 13: *OP-160's Extremely Fast Recovery Time from a 1mA Load Transient to 1mV (0.01%)*

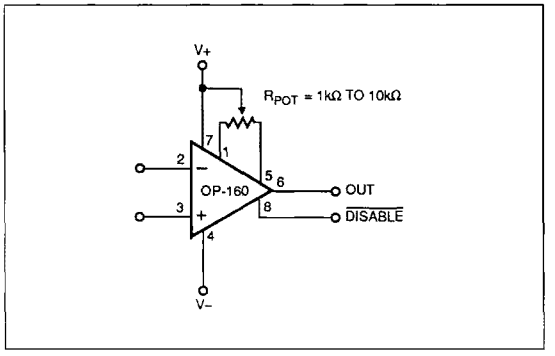


FIGURE 14: *Input Offset Voltage Nulling*

OFFSET VOLTAGE ADJUSTMENT

Offset voltage is adjusted with a 20kΩ potentiometer as shown in Figure 14. The potentiometer should be connected between pins 1 and 5 with its wiper connected to the V+ supply. The typical trim range is ±40mV.

$\overline{\text{DISABLE}}$ AMPLIFIER SHUTDOWN

Pin 8 of the OP-160, $\overline{\text{DISABLE}}$, is an amplifier shutdown control input. The OP-160 operates normally when Pin 8 is left floating. When greater than 1000µA is drawn from the $\overline{\text{DISABLE}}$ pin, the OP-160 is disabled. To draw current from the $\overline{\text{DISABLE}}$ pin, an open collector output logic gate or a discrete NPN transistor can be used as shown in Figure 15. An internal resistor limits the $\overline{\text{DISABLE}}$ current to around 500µA if the $\overline{\text{DISABLE}}$ pin is grounded with the OP-160 powered by ±15V supplies. These logic interface methods have the added advantage of level shifting the TTL signal to whatever supply voltage is used to power the OP-160.

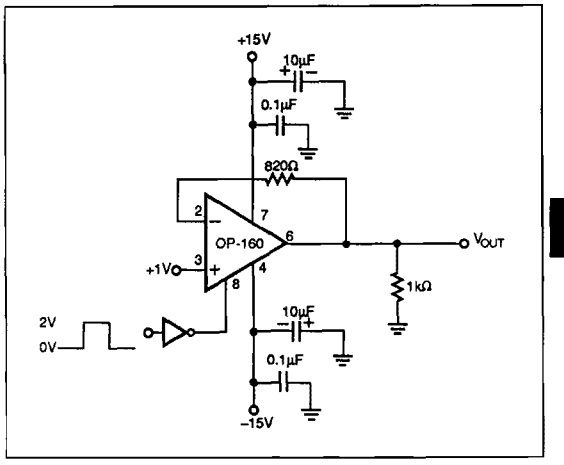


FIGURE 16: *$\overline{\text{DISABLE}}$ Turn-On/Turn-Off Test Circuit*

In the $\overline{\text{DISABLE}}$ mode, the OP-160 maintains 40dB of input-to-output isolation if the input signal remains below ±1.5V. Output resistance is very high, over 100kΩ, if the output is driven by signals of less than ±1.5V. Higher signals will be distorted.

Figure 16 shows a test circuit for measuring the turn-on and turn-off times for the OP-160. The OP-160 is in a gain of +1 with a +1V DC input. As the input pulse to the inverter rises its output falls, drawing current from the $\overline{\text{DISABLE}}$ pin and disabling the

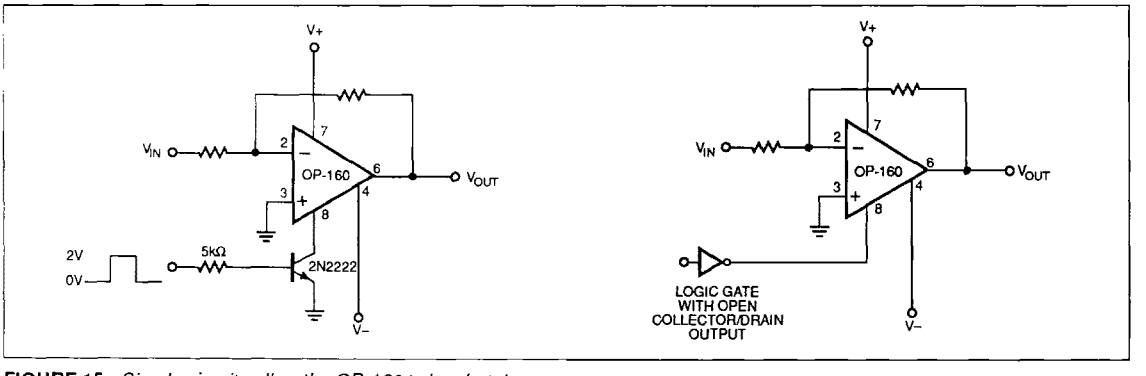


FIGURE 15: *Simple circuits allow the OP-160 to be shut down.*

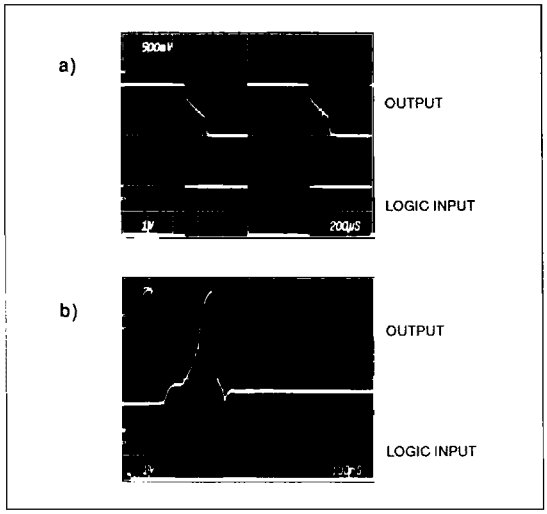


FIGURE 17: *(a) OP-160 turn-on and turn-off performance. (b) Expanded scale showing turn-on performance of the OP-160. Be aware of the high-frequency spike during turn-on.*

amplifier. The output voltage delay is shown in Figure 17 and takes 200µs to reach ground. The turn-on time is much quicker than the turn-off time. In this situation as the input to the inverter falls its output rises, returning the OP-160 to normal operation. The amplifier's output reaches its proper output voltage in 450ns.

OVERDRIVE RECOVERY

Figure 19 shows the overdrive recovery performance of the OP-160. Typical recovery time is 120ns from positive and negative overdrive.

APPLICATIONS

NONINVERTING AMPLIFIER

The OP-160 can be used as a voltage-follower or noninverting amplifier as shown in Figure 20. A current feedback amplifier in this configuration yields the same transfer function as a voltage feedback op amp:

$$\frac{V_{OUT}}{V_{IN}} = 1 + \frac{R_2}{R_1}$$

Remember to use a 820Ω feedback resistor in voltage-follower applications.

In noninverting applications, stray capacitance at the inverting input of a current feedback amplifier will cause peaking which will increase as the closed-loop gain decreases. The gain setting resistor, R_1, is in parallel with this stray capacitance creating a zero in the

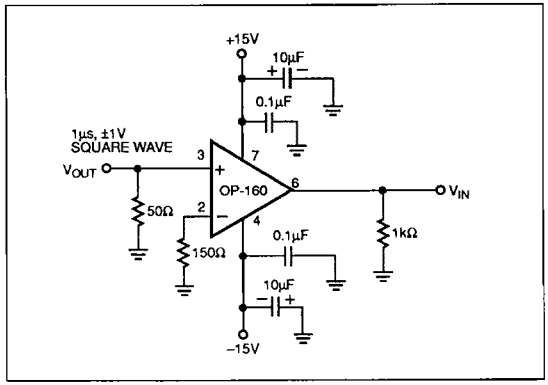


FIGURE 18: *Overdrive Recovery Test Circuit*

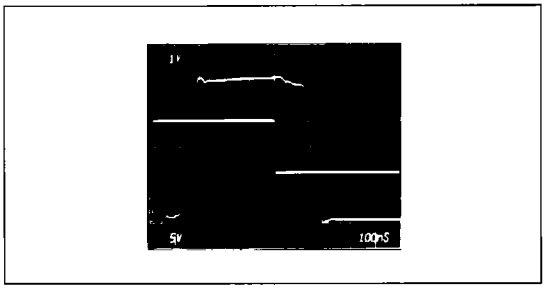


FIGURE 19: *The OP-160 recovers from both positive and negative overdrive in 120ns.*

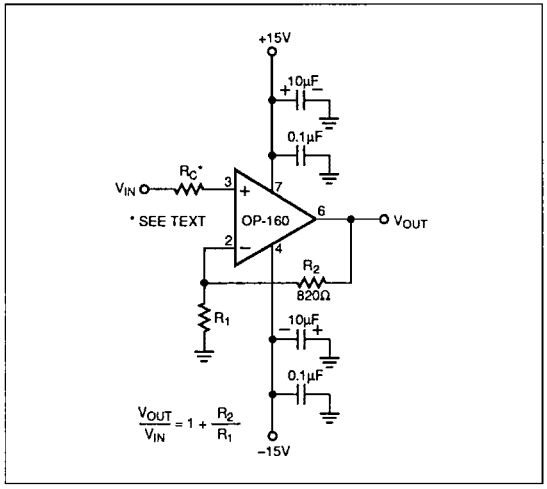


FIGURE 20: *The OP-160 as a voltage follower or noninverting amplifier.*

closed-loop response. For large noninverting gains, R_1 is small, creating a very high-frequency open-loop pole which has limited effect on the closed-loop response. As the noninverting gain is decreased, R_1 becomes larger and the stray zero becomes lower in frequency, having a much greater effect on the closed-loop response. To reduce peaking at low noninverting gains, place a series resistor, R_C, in series with the noninverting input as shown in Figure 20. This resistor combines with the stray capacitance at the noninverting input to form a low-pass filter that will reduce the peaking. The value of R_C should be determined experimentally in the actual PCB layout. Less peaking will occur in inverting gain configurations since the inverting input is a virtual ground which forces a constant voltage across the stray capacitance.

A common practice to stabilize voltage feedback op amps is to use a capacitor across the feedback resistance. This creates a zero in the voltage feedback amplifier response to offset the loss of phase margin due to a parasitic pole. In current feedback amplifiers, this technique will cause the amplifier to become unstable because the closed-loop bandwidth will increase beyond the stable operating frequency.

INVERTING AMPLIFIER

The OP-160 is also capable of operation as an inverting amplifier (see Figure 21). The transfer function of this circuit is identical to that using a voltage feedback op amp:

$$\frac{V_{OUT}}{V_{IN}} = -\frac{R_2}{R_1}$$

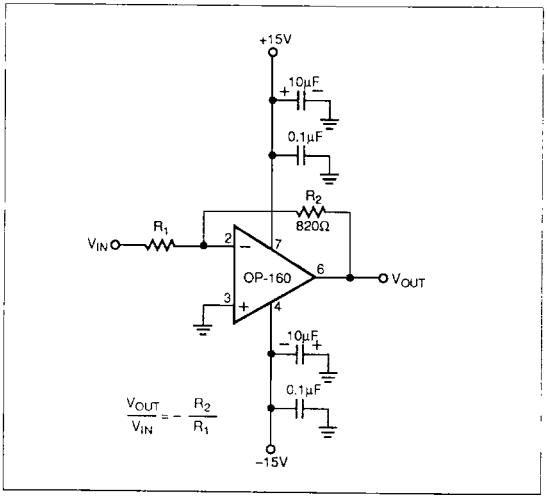


FIGURE 21: *The OP-160 as an inverting amplifier.*

USING CURRENT FEEDBACK OP AMPS IN INTEGRATOR APPLICATIONS

The small-signal model of a current feedback op amp shown earlier in Figure 3 assumes a non-varying value of feedback impedance. A non-varying feedback impedance ensures that the bandwidth of the amplifier does not extend beyond its 180° phase shift point and create unwanted oscillations. In integrator circuits, the feedback element is a capacitor whose impedance does vary with frequency. By definition then, integrator applications using current feedback amplifiers should be unstable. However, a simple trick, shown in Figure 22, enables high-speed, wide bandwidth current feedback op amps to be used in integrator applications.

Resistor R_F is placed between an artificial sum node and the inverting input of the amplifier. This resistor maintains a minimum value of feedback impedance over all frequencies. At high signal frequencies, the integrator capacitor, C_1, is a short circuit; the feedback impedance is equal to R_F only and the amplifier has maximum bandwidth. At low frequencies, C_1 adds to the overall feedback impedance. This lowers the amplifier's bandwidth but not enough to affect the integrator's performance.

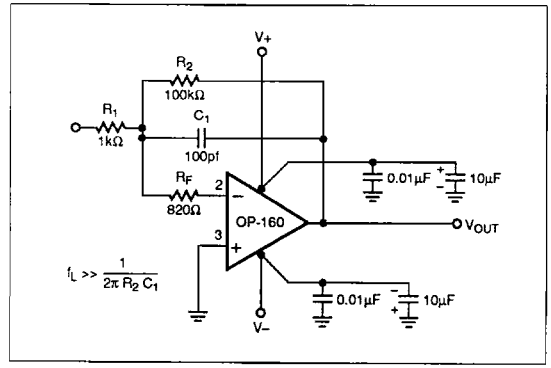


FIGURE 22: *An Integrator Using a Current Feedback Op Amp*

Figure 23 shows the gain and phase performance of the integrator. The integrator has the desired one-pole response for signal frequencies

$f_C >> 1/(2\pi R_2 C_1) \approx 16kHz$.

A more strenuous test of integrator performance is the pulse response. Ideally, this should be a linear ramp. The current feedback integrator's pulse response is exhibited in Figure 24. The response closely approximates the ideal linear ramp.

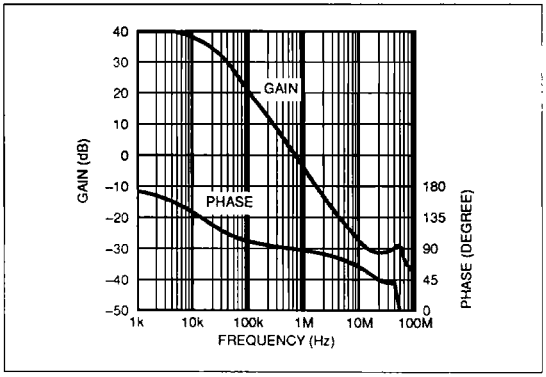


FIGURE 23: *Gain and phase response of the integrator shows a one-pole response.*

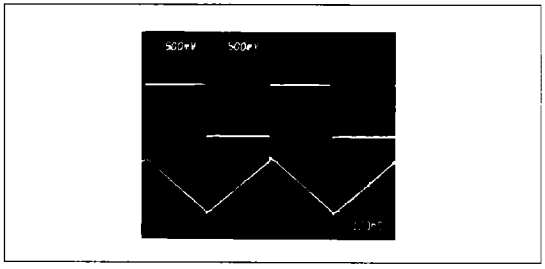


FIGURE 24: *Pulse response of the current feedback integrator. f = 2MHz.*

ACHIEVING FLAT GAIN RESPONSE WITH CURRENT FEEDBACK OP AMPS

In high-performance systems, flat gain response is often required. Current feedback op amps provide wide bandwidth performance but even these may not fulfill the gain flatness requirements of some systems.

Current feedback op amps exhibit both gain roll-off and peaking as shown in Figure 25. Peaking is primarily due to parasitic capacitance; gain roll-off is determined by the amount and type of load on the amplifier. Peaking is controlled by careful layout and circuit design; however, its cause can provide a method of improving gain flatness over a desired frequency range.

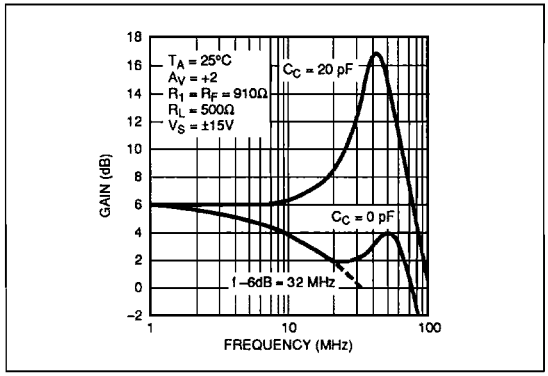


FIGURE 25: *Gain roll-off and peaking of current feedback amplifiers is dependent upon a number of factors including loading and parasitic capacitance.*

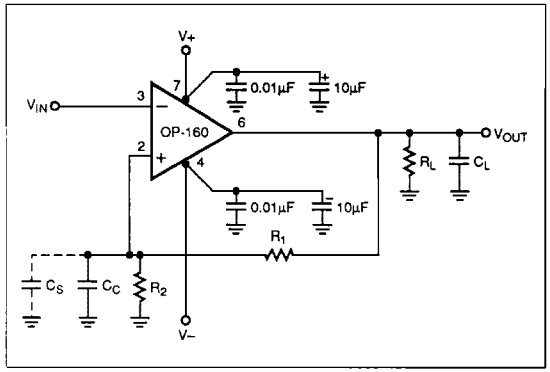


FIGURE 26: *A current feedback op amp configured for noninverting gain. Parasitic capacitances affecting gain are also shown.*

Consider the noninverting amplifier of Figure 26. The gain equals:

$$1 + \frac{R_2}{R_1 // Z_{(C_C // C_S)}},$$

and at low frequencies

$$A_V = 1 + \frac{R_2}{R_1} = 1 + \frac{910\Omega}{910\Omega} = 2$$

At higher frequencies the gain increases or peaks due to the effect of the parasitic capacitance, C_S, on the gain equation. Any capacitance at the inverting input will create a zero in the amplifier's response. This fact can be used to compensate for gain roll-off due to loading on the amplifier.

Begin by measuring or estimating the amplifier's –6dB point (this is the frequency at which the output signal is half its original amplitude). This can be easily determined from a network analyzer plot of the amplifier's frequency performance. From this the amount of capacitance, C_C, which will double the gain at the –6dB frequency and restore the original gain, can be determined.

From the –6dB frequency, C_C can be calculated:

$$C_C = C_S + \frac{1}{2\pi R_1 f_{-6dB}} + \frac{1}{2\pi R_2 f_{-6dB}}$$

for noninverting configuration, where C_S is the combination of the amplifier's input capacitance and the stray capacitance at the input.

In the example shown,

C_S = 9pF = OP-160 input capacitance (4pF) + stray capacitance (5pF)

$$C_S = 9pF + \frac{1}{2\pi(910\Omega)32MHz} + \frac{1}{2\pi(910\Omega)32MHz}$$

≈ 20pF

Figure 27 is an expanded scale plot of the gain performance of the compensated amplifier at A_V = +2. Gain performance is flat to ±0.1dB out to beyond 9MHz. For low gains ($A_V \leq 5$) peaking will be increased. At higher gains, gain flatness can be significantly improved without gain peaking. Figure 28 depicts the OP-160 with A_V = +10. In this example $f_{-6dB} \approx 22$ MHz so,

$$C_S = 9pF + \frac{1}{2\pi(91\Omega)22MHz} + \frac{1}{2\pi(820\Omega)22MHz}$$

= 97pF

The nearest standard capacitor value is 100pF.

Gain performance is flat to 0.5dB to 30MHz and the amplifier's –3dB point is 38MHz. This gives the amplifier an effective gain-bandwidth of 380MHz! Compensating the OP-160 does not effect the pulse response as shown in Figure 29.

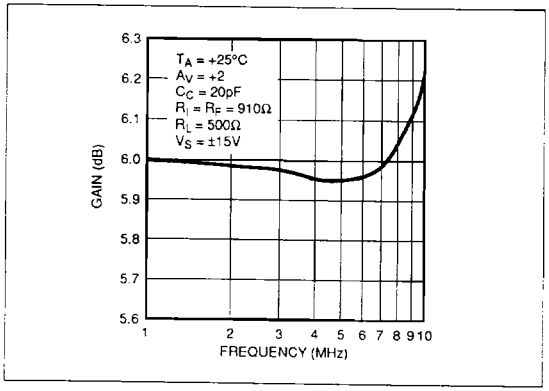


FIGURE 27: *Expanded Gain/Frequency Graph of the Compensated Amplifier, A_V = +2*

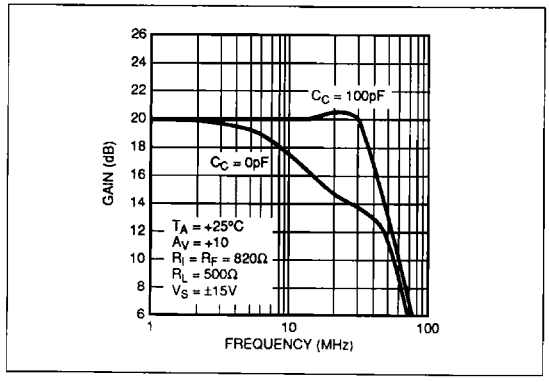


FIGURE 28: *Gain/frequency graph for the compensated amplifier, A_V = +10, showing the effect of the compensation capacitance, C_C, on gain flatness.*

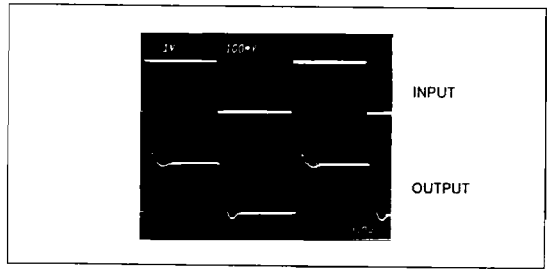


FIGURE 29: *Pulse Response of the OP-160 in a Gain of +10 Compensated for Gain Flatness*

OP-160 SPICE MACRO-MODEL

Figures 30 and 31 show the SPICE macro-model for the OP-160 high-speed, current feedback operational amplifier. This model was tested with, and is compatible with PSpice* and HSpice**. The schematic and net-list are included here so that the model can easily be used. This model uses a unique current feedback topology to accurately model both the AC and DC characteristics of the OP-160. In addition, this model can accommodate any number of poles and zeros to further shape the AC response.

The OP-160 SPICE macro-model uses four BJT transistors to create the input buffer as in the actual device. However, the rest of the model contains only ideal linear elements and ideal diodes to model the OP-160's behavior. Using only four transistors reduces simulation time and simplifies model development. It simulates important DC parameters such as V_{OS}, I_B, CMR, V_O and I_{SY}. AC parameters such as slew rate, open-loop transimpedance and phase response and CMR changes with frequency are also simulated by the model. In addition, the model includes the change in input bias current with varying common-mode and power supply voltages. Both output swing and supply current are accurately modelled.

One aspect of the OP-160's behavior is that slew rate varies with closed-loop gain. Slew rate of the basic model is set to the typical values for the OP-160 in a gain of +1. For other gains, the rising and falling slew rates can be adjusted by varying the values of V_1 and V_2 in the model. Slew rates for various gains can be determined from Figures 6a and 6b.

$$\text{Rising Slew Rate} = \frac{V_1 + 0.6V}{(1k\Omega)(5pF)}$$

$$\text{Falling Slew Rate} = \frac{V_2 + 0.6V}{(1k\Omega)(5pF)}$$

To keep the OP-160 model as simple as possible and thus save computer and development time, not all features of the op amp were modelled as listed below:

- PSR
- Crosstalk
- No limits on power supply voltages
- Maximum input voltage range
- Temperature effects (i.e., model parameters are assumed at 25°C)
- Input noise voltage and current sources
- Parameter variations for Monte Carlo analysis (i.e., all parameters are typical only)

These parameters are considered second-order effects and are not considered necessary for circuit simulation under normal operating conditions. However, users can easily add these functions as needed.

* PSpice is a registered trademark of MicroSim Corporation
** HSPICE is a tradename of Meta-Software, Inc.

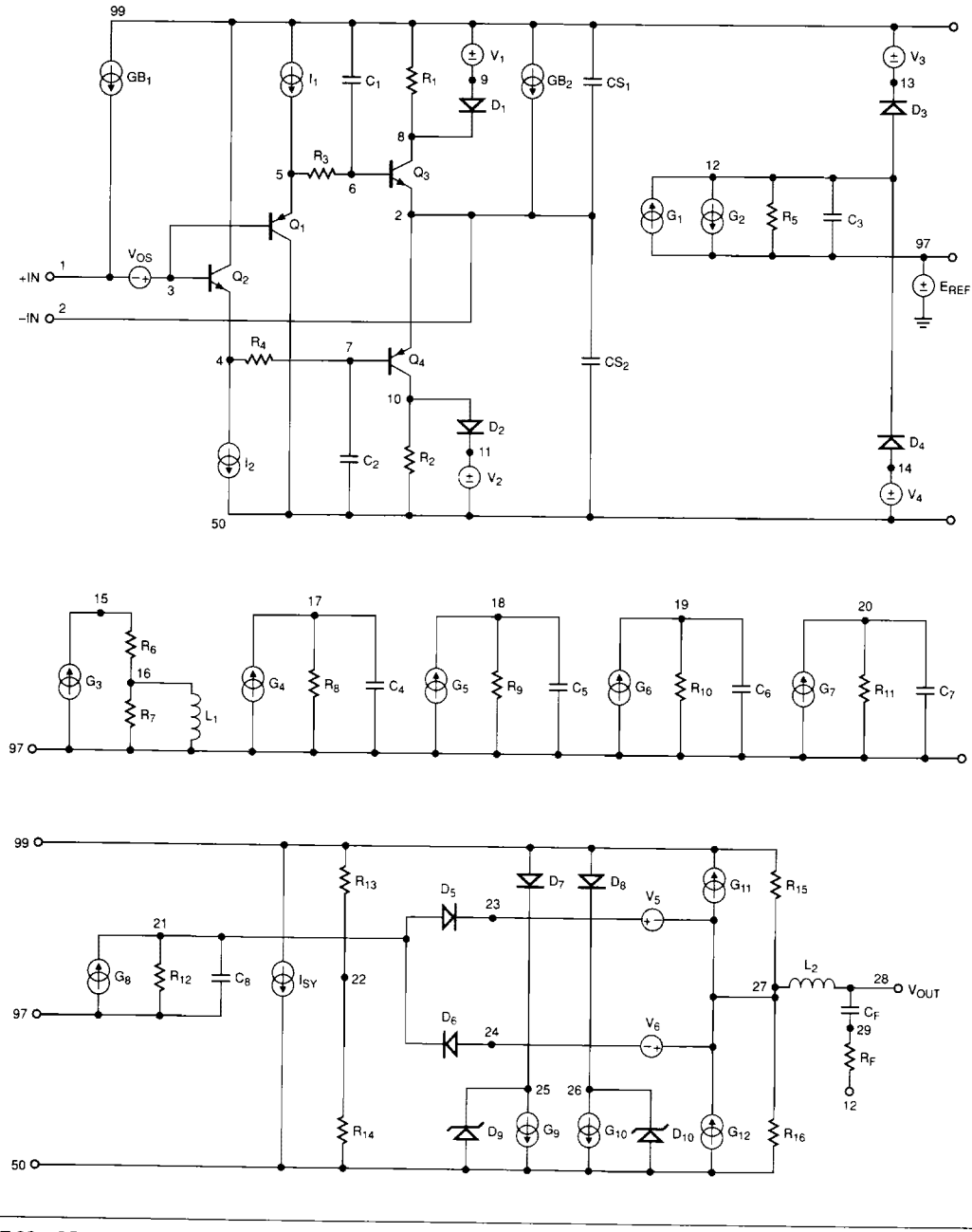


FIGURE 30: *OP-160 SPICE Model*

```
* OP-160 MACRO-MODEL © PMI 1990
*
* NODE ASSIGNMENTS
*                    NONINVERTING INPUT
*                    | INVERTING INPUT
*                    | | OUTPUT
*                    | | | POSITIVE SUPPLY
*                    | | | | NEGATIVE SUPPLY
*                    | | | | |
* SUBCKT OP-160  1  2  24  99  50
*
* INPUT STAGE
*
R1    99  8       1K
R2    10  50      1K
V1    99  9       9.4
D1    9   8       DX
V2    11  50      4.4
D2    10  11      DX
I1    99  5       125U
I2    4   50      125U
Q1    50  3   5   QP
Q2    99  3   4   QN
Q3    8   6   2   QN
Q4    10  7   2   QP
R3    5   6       143K
R4    4   7       143K
C1    99  6       0.0133P
C2    50  7       0.0133P
*
* INPUT ERROR SOURCES
*
GB1   99  1       POLY(1) 1 22 2E-7 4E-8
GB2   99  2       POLY(1) 1 22 6E-6 4E-8
VOS   3   1       1E-3
CS1   99  2       2.5E-12
CS2   50  2       2.5E-12
*
EREF  97  0       22 0 1
*
* GAIN STAGE & DOMINANT POLE
*
R5    12  97      5E6
C3    12  97      5P
G1    97  12      99 8 1E-3
G2    12  97      10 50 1E-3
V3    99  13      2.2
V4    14  50      2.2
D3    12  13      DX
D4    14  12      DX
CF    29  28      30P
RF    12  29      300
*
* ZERO/POLE PAIR AT 50MHZ/300MHZ
*
R6    15  16      1E6
L1    16  97      2.65E-3
R7    16  97      5E6
G3    97  15      12 22 1E-6
*
* POLE AT 300MHZ
*
R8    17  97      1E6
C4    17  97      0.531E-15
G4    97  17      15 22 1E-6
*
* POLE AT 300MHZ
*
R9    18  97      1E6
C5    18  97      0.531E-15
G5    97  18      17 22 1E-6
*
* POLE AT 500MHZ
*
R10   19  97      1E6
C6    19  97      0.318E-15
G6    97  19      18 22 1E-6
*
* POLE AT 500MHZ
*
R11   20  97      1E6
C7    20  97      0.318E-15
G7    97  20      19 22 1E-6
*
* POLE AT 500MHZ
*
R12   21  97      1E6
C8    21  97      0.318E-15
G8    97  21      20 22 1E-6
*
* OUTPUT STAGE
*
ISY   99  50      1.75E-3
R13   22  99      3.333E3
R14   22  50      3.333E3
R15   27  99      40
R16   27  50      40
L2    27  28      4E-8
G9    25  50      21 27 25E-3
G10   26  50      27 21 25E-3
G11   27  99      99 21 25E-3
G12   50  27      21 50 25E-3
V5    23  27      1.55
V6    27  24      1.55
D5    21  23      DX
D6    24  21      DX
D7    99  25      DX
D8    99  26      DX
D9    50  25      DY
D10   50  26      DY
*
* MODELS USED
*
.MODEL QN  NPN (BF=1E9 IS=1E-15 VAF=92)
.MODEL QP  PNP (BF=1E9 IS=1E-15 VAF=92)
.MODEL DX  D(IS=1E-15)
.MODEL DY  D(IS=1E-15 BV=50)
.ENDS OP-160
```

FIGURE 31: *OP-160 SPICE Net-List*